Search	<b>Notes</b>
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/645,482	KIM ET AL.
Examiner	Art Unit
Jean B. Corrielus	2611

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	229-234	1/29/2007	JBC
	350;285		
708	300;323		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEAR( (INCLUDING SE	CH NOTES	S RATEGY	)
		DATE	EXMR
East		1/29/2007	JBC
Plus Search		1/29/2007	JBC
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